

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09/820,143</u>	Prepared by <u>KW</u>	Tracking Number <u>05888458</u>	
Examiner-GAU <u>2881</u>	Date <u>2/3/04</u>	Week Date <u>1/12/2004</u>	
	No. of queries <u>2 IFN</u>		

JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	<u>p. PTO-1449</u>
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

CLAIMS

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- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
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- g. Amendments
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MESSAGE

PTO-1449: Please either
initial or line through citations.
(1 page)

Verify Primary Examiner
name. (2 pages)

Thank you

initials KW

RESPONSE

initials

Form PTO-1449 (MODIFIED)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 039153-0405 (P0945)		SERIAL NO. 09/820, 1211		
<div style="position: relative;"> <div style="position: absolute; top: 0; left: 0; width: 100%; height: 100%; border: 1px solid black; border-radius: 50%; text-align: center; line-height: 100px; font-size: 20px; transform: rotate(-45deg);"> OIP E JCA2 JUL 30 2001 PATENT & TRADEMARK OFFICE </div> <div style="position: absolute; top: 10px; left: 10px;"> INFORMATION DISCLOSURE CITATION <small>(Use several sheets if necessary)</small> </div> </div>				APPLICANT Uzodinma Okoranyanwu et al		<div style="border: 1px solid black; padding: 5px; transform: rotate(-90deg); position: absolute; right: -50px; top: 50%; font-size: 10px;"> RECEIVED JUL 30 2001 TECHNOLOGY CENTER-2800 </div>		
				FILING DATE 03/28/2001			GROUP ART UNIT 2878	
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE	
		09/819,342		Shields et al			03/28/01	
		09/819,343		Gabriel et al			03/28/01	
		09/819,344		Okoroanyanwu et al			03/28/01	
		09/819,552		Gabriel et al			03/28/01	
		09/819,692		Okoroanyanwu et al			03/28/01	
		6,107,172	08/22/00	Yang et al	438	585		
		6,103,457	08/15/00	Gabriel	430	318		
		5,965,461	10/12/99	Yang et al	438	717		
		5,003,178	03/26/91	Livesay	250	492.300		
FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
							YES	NO
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
		Livesay, W. R., "Large-area electron-beam source," Journal of Vacuum Science & Technology B, Vol. 11, No. 6, Nov./Dec. 1993, pp. 2304-2308, American Vacuum Society						
		Yang, J. J. et al, "Electron Beam Processing for Spin-on Polymers and Its Applications to Back-End-of-Line (BEOL) Integration," Materials Research Society Symposium Proceedings, Vol. 511, 1998, pp. 49-55, Materials Research Society						
		Ross et al, "Plasma Etch Characteristics of Electron Beam Processed Photoresist," The Society of Photo-Optical Instrumentation Engineers, Vol. 2438, 1995, pp. 803-816, SPIE-The International Society for Optical Engineering						
		Grün, Von A. E., "Lumineszenz-photometrische Messungen der Energieabsorption im Strahlungsfeld von Elektronenquellen Eindimensionaler Fall in Luft," Zeitschrift für Naturforschung, Vol. 12a, 1957, pp. 89-95, Publisher: Zeitschrift für Naturforschung; full English Translation attached (11 pgs.)						
EXAMINER				DATE CONSIDERED				
<p>* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include any copy of this form with next communication to applicant.</p>								